

GPT-12000 Series

AC/DC/IR/GB Electrical Safety Analyzer

FEATURES

- 200VA AC Test Capacity
- Comply with IEC 61010-2-034
- 7" TFT LCD
- Manual / Auto Mode
- True RMS Current Measurement
- Zero Crossing Turn-on Operation
- Controllable Ramp-up & Ramp-down Time
- Capacitive Load Testing Capability up to 47μF
- Statistics Function
- Sweep Function for DUT Characteristic Analysis
- USB Storage Available
- Rear Panel Output Available
- Interface: RS-232C, USB Host/Device, Signal I/O and GPIB (Opt.)
- Universal Power Input



GW Instek introduces the flagship model (200VA output capacity) safety analyzer-the GPT-12000 series, which is the first safety analyzer in the world to comply with IEC 61010-2-034 (Safety requirement for electrical requirement for measurement, control and laboratory use – particular requirements for measurement equipment for insulation resistance and test equipment for electric strength), which stipulates that the requirements of the software and hardware interfaces must be followed while designing high voltage and insulation resistance test and measurement instruments so as to ensure that users are provided with necessary protection and warning while using the instruments.

The GPT-12000 series safety analyzer has four models: GPT-12004 features AC/DC withstanding voltage test, insulation resistance test, AC ground bond test and continuity test; GPT-12003 conducts AC/DC withstanding voltage test, insulation resistance test, and continuity test; GPT-12002 carries out AC/DC withstanding voltage test and continuity test. The entire series provides an output capacity of 200VA and utilizes a high-efficient PWM amplifier to effectively exclude the influence from the fluctuating input voltage or distorted waveforms so as to guarantee a stable high-voltage output while conducting AC withstanding voltage test on the DUT to meet the safety regulations such as IEC \cdot EN \cdot UL \cdot CSA \cdot GB \cdot JIS that demand the test requirements for various electronic/electrical products or parts.

To comply with IEC 61010-2-034 requirements, the series takes into account of safety by adopting the double insulation design for input power supply and output voltage to enhance user safety. Additionally, the retracted on-off switch design (START key) and various (optional) mechanisms for test activation (for instance, press and hold for 1 second to activate, activation by pressing double keys, etc.) are incorporated into the series to avoid accidentally touching that results in high voltage/large current output causing damage and danger to products or users. High illumination LED lights (flashing or permanently lit) and a high volume audial indicator are included in designing the series to provide warnings of the status of the on-going tests or judgement results from the safety analyzer. On top of that, the DUT will be automatically discharged to the safe voltage (approximately 30V) after each test to prevent large residual test voltage from causing harm to users.

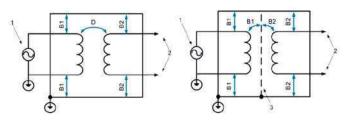
The series utilizes 7-inch color TFT LCD and inherits the consistent simplicity key design style of the product family to allow users to experience easy operations and a clear observation of the test results. The major test functions include AC withstanding voltage test (AC 5kV/40mA), DC withstanding voltage test (DC 6kV/10mA), insulation resistance test (DC $50V-1200V/50G\Omega$ max.), ground bond test (AC $32A/650m\Omega$ max.), and grounding continuity test (DC 100mA fixed/100mA fixed/100mA max.). The series also collocates with superb output adjustment resolution, measurement resolution (AC withstanding voltage: $1\mu A$; DC withstanding voltage: $0.1\mu A$; insulation resistance: $0.1M\Omega$; ground bond: $0.1M\Omega$; continuity test: 0.01Ω), controllable voltage ramp up and ramp down time settings, and upper/lower limit judgement settings, and large capacitance test capability (up to 47uF) for DUT with large capacitance such as surge absorber and large capacitance on the input terminal of EMC/EMI prevention. For Insulation resistance, provides 10mA pre-charged current (fixed) to first rapidly fully charge the DUT's capacitive load and then to conduct test and measurement so as to avoid misjudgment from fluctuating inrush current. All the above features of the series facilitate a more flexible execution of the required tests so that users can obtain accurate test and measurement results.

The statistic function is the highlight of the series. Test items, number of tests, judgement results are recoded after testing and the test results can be shown by bar graph on the display. Users can immediately learn the status of product tests and judgement distribution during the manufacturing process without using a PC. The other strong feature is the sweep function, which can be used for the analysis on product's crash point. Users can use the sweep mode to see the curve diagram of the test results after finishing the functional tests. Users can also select any time point during the process to analyze the relation between voltage and current (when ACW or DCW is selected). The test result of the certain period of time can be swept by setting start and stop time points to analyze the relation between voltage and current under that time frame. Furthermore, the tabular continuity test function can combine 10 manual memory sets to carry out automatic tests or 9 manual memory sets with one connection device to connect next automatic test so as to increase the test items of the continuity test. Users can obtain various test values and judgement results without switching to a different display screen.

Other functions and features of the GPT-12000 series include 100 sets of manual test memory for the storage of different test conditions; rear output terminal for system integration; front panel remote control terminal mount/rear panel Signal I/O for users to conveniently control the analyzer's output/stop based upon the requirements. The USB storage function allows test results to be stored in the USB flash drive to save the trouble of using a PC, and the function is conducive to the follow-up data analysis. For users with the requirements of PC control and test results recording, the series also provides RS-232C, USB and GPIB (optional)

PANEL INTRODUCTION





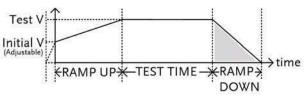
Providing the markets with safe electronic products is the responsibility of every manufacturer! Similarly, safety analyzer that tests whether electronic products meet safety regulations must attach the importance to the safety it provides! GPT-12000 is the world's first safety analyzer to comply with IEC 61010-2-034 (Safety requirement for electrical requirement for measurement, control and laboratory use — particular requirements for measurement equipment for insulation resistance and test equipment for electric strength). Apart from this, the safety considerations also include double insulation for input and output voltages, safe output/warning mechanism, post-test discharge mechanism, etc. to ensure user safety during the operation.

High Adjustment & Measurement Resolution

High Accuracy and High Resolution Testing Performance

For production tests and characteristic verification, the GPT-12000 series provides a withstand voltage test voltage (AC 5kV/DC 6kV) that can be adjusted in 1V steps with current measurement resolutions up to 1 μ A (ACW) or 0.1 μ A (DCW) to realize the small leakage current measurement for products or components. In addition, the insulation resistance test voltage can be adjusted in 50V steps from a DC output range of 50V to 1200V, and the resistance measurement resolution can reach 0.1 $M\Omega$. Since most safety regulations require AC power supply for ground bond test, the GPT-12000 series provides 8Vac (open) and 3A to 32Aac current for ground bond test with a resistance measurement resolution of 0.1 $m\Omega$. The entire series provides the continuity grounding test function with a 100mAdc (fixed) test source and a measurement resolution of 0.01 Ω to detect if the tested equipment is correctly grounded. With these functions, users can perform various safety tests and verifications with high accuracy and reliability.

C. Flexible Supplementary Testing Mechanism

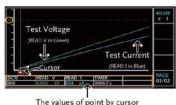


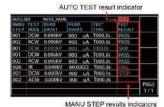
Testing Period Timing

To make tests compliant with the test requirements of relevant safety regulations, the GPT-12000 series provides a more flexible output sequence setting starting from the start point of the test. Taking the AC/DC withstand voltage test as an example, the initial voltage can be set. Users determine the initial voltage ratio (i.e., the ratio of the rated test voltage), and then the voltage ramp up can also be set to reduce the risk of insulation breakdown or damage to the DUT caused by transient high voltages. After the rated test voltage is reached, the upper/lower limit judgement window, delay judgment and test timer mechanism can be set to assist users to conduct tests smoothly and correctly. The new voltage ramp down time setting allows users to test with a ramp down voltage to avoid the impact of excessively high rated test voltage to instantaneous discharge on the DUT.

With respect to the insulation resistance test, other than the newly added grounding mode to perform test in accordance with the actual grounding state of the DUT, the setting mechanism of the supplementary upper/lower limit judgement is also added to shorten the test time. The user-definable mode mechanisms include: STOP ON FAIL: The test is terminated as soon as the FAIL setting is met; STOP ON PASS: The test is terminated as long as the PASS setting is met, or TIMER: judgement is conducted when the timer time is reached.

D. Sweep and Tabular Automatic Test





Sweep Function

Tabular Automatic Test

The GPT-12000 series features a unique sweep function, which displays a curve diagram of the test results of the DUT. Test readings are recorded point by point based on the applied test voltage or current and relevant settings (such as initial voltage, ramp up time, test time, or ramp down time). After the test is completed, users can learn the amount of applied energy (voltage or current) at a specific time point and the results of measurement parameters by moving the cursor position so as to help users understand the changes of the measurement parameters (current or resistance) during the test. The function can also be used to determine the critical break down of the DUT. With respect to the automatic test function, each automatic test has up to 10 manual test items and all related settings and result judgement are presented in a table, so that users can easily obtain the results of all test items at a time. Other than that, if there are multiple automatic test connection requirements, uses only need to select CON in the last item of the table to automatically connect the automatic measurement of the next position (such as AUTO-012~ AUTO-013)

E. Statistic and Analysis

PASS, FAIL Amounts & TOTAL Amounts





Analysis

The GPT-12000 series provides the statistic function, which can record the test functions and judgment results in the temporary storage area (60,000 lots max.). Users can immediately learn the test of each function during the test without using a PC. The distribution of the good products can be analyzed to understand the quality of the batch based on the data. If most of them fall at the critical point that is close to be categorized as defect product, the results can be found in the test process in time so as to improve the manufacturing process and stop the defect products from entering the markets to ensure the reliability of products after leaving the factory.

Complete test Data retrieval Interface





SIGNAL IO Selection for AUTO Test (blue zone)

Usb Storage Function

Signal I/O Self-defined Signal I/O

In order to facilitate users to analyze the results of the safety test, GPT-12000 provides the USB storage function in addition to its own statistic and analysis functions. When a USB is inserted and the storage function is activated, each time the test button (START) is pressed, the test results of all tests (every manual or automatic test item) are automatically saved to the USB in the form of a text file (txt) for follow-up analysis. For interface connections, the GPT-12000 series offers external control or a variety of remotely connected ports such as a signal I/O port that can be used to connect an external controller or PLC. The signal I/O's output signal pins can be self-defined so as to collocate with various PLC control requirements. Besides, the entire series is equipped with RS-232C and USB device (GPIB is optional) for easy retrieval of test data and results by connecting a PC.

	SPECIFICATIONS	
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AC WITHSTANDING		
Output-Voltage Range	0.050kV~5.000kV	
Output-Voltage Resolution Output-Voltage Accuracy	1V	
Maximum Rated Load	±(1% of setting + 5V) [no load] 200 VA (5kV/40mA)	
Maximum Rated Current	40mA (0.5kV< V≦5kV); 10mA (0.05kV≦ V ≦0.5kV)	
Output-Voltage Waveform	Sine wave	
Output-Voltage Frequency	50 Hz / 60 Hz selectable	
Voltage Regulation	±(1% + 5V) [maximum rated load no load]	
Voltmeter Accuracy	±(1% of reading + 5V)	
Current Measurement Range	1μA~40.00mA	
Current Best Resolution	1μΑ / 10μΑ	
Current Measurement Accuracy	±(1.5% of reading + 30μA)	
Window Comparator Method	Yes	
ARC Detect	Yes	
RAMP UP (Rise Time)	0.1s~999.9s 0.0s~999.9s	
RAMP DOWN (Fall Time)	0.05-273-35 OFF, 0.35-999.9s	
TIMER (Test Time) WAIT TIME	0.0s~999.9s	
GND	ON/OFF	
DC WITHSTANDING		
Output-Voltage Range	0.050kV~6.000kV	
Output-Voltage Resolution	TV TV	
Output-Voltage Accuracy	±(1% of setting + 5V) [no load]	
Maximum Rated Load	50W (5kV/10mA)	
Maximum Rated Current	$10mA (0.5kV < V \le 6kV); 2mA (0.05kV \le V \le 0.5kV)$	
Voltage Regulation	±(1% + 5V) [maximum rated load no load]	
Voltmeter Accuracy	±(1% of reading + 5V)	
Current Measurement Range	1μΑ~10.00mA	
Current Best Resolution Current Measurement Accuracy	0.1µA /1µA /10µA	
Window Comparator Method	±(1.5% of reading + 3μA) when I Reading < 1mA; ±(1.5% of reading + 30μA) when I Reading≧1mA Yes	
ARC Detect	Yes	
RAMP UP (Rise Time)	0.1s~999.9s	
RAMP DOWN (Fall Time)	0.0s-999.9s	
TIMER (Test Time)	OFF, 0.3s~999.9s	
WAIT TIME	0.0s-999.9s	
GND	ON/OFF	
INSULATION RESISTANCE		
Output Voltage	50V~1200V dc	
Output-Voltage Resolution	50V 1/19/ of cetting 15V) (so lead)	
Output-Voltage Accuracy	±(1% of setting + 5V) [no load]	
Resistance Measurement Test Voltage Display Range	Measurement Range / Accuracy	
50V≦V≦100V 0.1MΩ~10.00GΩ	$0.1M\Omega \sim 1M\Omega$: $\pm (5\% \text{ of reading} + 3 \text{ count})$; $1 M\Omega \sim 50 M\Omega$: $\pm (5\% \text{ of reading} + 1 \text{ count})$; $51M\Omega \sim 2G\Omega$: $\pm (10\% \text{ of reading} + 1 \text{ count})$	
$\frac{1500 \le V \le 450V 0.1M \Omega \sim 20.00G \Omega}{500V \le V \le 1200V 0.1M \Omega \sim 50.00G \Omega}$	$0.1M\Omega \sim 1M\Omega$: $\pm (5\% \text{ of reading} + 1 \text{ count})$; $1 M\Omega \sim 500M\Omega$: $\pm (5\% \text{ of reading} + 1 \text{ count})$;	
300V ⊇ V ⊇ 1200V 0.1M 12~30.00G 12	$0.1 \text{M}\Omega^{-1} \text{M}\Omega$. $\pm (3\% \text{ of reading} + 3 \text{ count})$; $1 \text{ M}\Omega^{-3} \text{ od} \text{M}\Omega$. $\pm (3\% \text{ of reading} + 1 \text{ count})$; $10 \text{G}\Omega \sim 50 \text{G}\Omega$: $\pm (20\% \text{ of reading} + 1 \text{ count})$	
Voltage Regulation	±(1% + 5V) [maximum rated load no load]	
Voltmeter Accuracy	±(1% of reading + 5V)	
Short-Circuit Current	10mA max.	
Output Impedance	2kΩ	
Window Comparator Method	Yes	
RAMP UP (Rise Time)	0.1s~999.9s	
RAMP DOWN (Fall Time)	0.0s-999.9s	
TIMER (Test Time) WAIT TIME	0.3s~999.9s 0.0s~999.9s	
GND	ON/OFF	
GROUND BOND	3.075.1	
Output-Current	03.00A-32.00A ac	
Output-Current Resolution	0.01A	
Output-Current Accuracy	$3A \le 1 \le 8A : \pm (1\% \text{ of reading } + 0.2A); 8A < 1 \le 32A : \pm (1\% \text{ of reading } + 0.05A)$	
Test-Voltage	8Vac max (open circuit)	
Test-Voltage Frequency	50Hz/60Hz selectable	
Ohmmeter Measurement Range	$1m\Omega\sim 650m\Omega$	
Ohmmeter Measurement Resolution	0.1mΩ	
Ohmmeter Measurement Accuracy Window Comparator Method	$\pm (1\% \text{ of reading} + 2 \text{ m}\Omega)$ Yes	
TIMER (Test Time)	0.3s~999.9s	
Test Method	Four Terminal	
GND	ON/OFF	
CONTINUITY TEST		
Output-Current	100mA dc (fixed) 0.10Ω~ 70.00Ω	
Ohmmeter Measurement Range		
Ohmmeter Measurement Resolution	0.01Ω	
Ohmmeter Measurement Accuracy Window Comparator Method	$\pm (10\% \text{ of reading} + 2 \Omega)$ Yes	
TIMER (Test Time)	0.3s-999.9s	
MEMORY		
Single Step Memory	MANU: 100 blocks	
Automatic Testing Memory	AUTO : 100 blocks, Manu per auto : 10	
INTERFACE		
Standard (Front)	REMOTE, USB host	
Standard (Rear)	Rear Output, RS-232C, USB device, Signal I/O,	
Option	GPIB	
DICDLAY		
DISPLAY		
	7" color LCD	
DISPLAY POWER SOURCE		
POWER SOURCE	7" color LCD AC 100V~240V ± 10%, 50Hz/60Hz; Power consumption : Max. 400VA	
	AC 100V~240V ± 10%, 50Hz/60Hz; Power consumption : Max. 400VA	
POWER SOURCE	AC 100V~240V ± 10%, 50Hz/60Hz; Power consumption : Max. 400VA 380(W) x 148(H) x 454(D) mm; Approx. 15kg	
POWER SOURCE	AC 100V~240V ± 10%, 50Hz/60Hz; Power consumption : Max. 400VA	

GPT-12004 AC/DC/IR/GB Electrical Safety Analyzer GPT-12003 AC/DC/IR Electrical Safety Analyzer GPT-12002 AC/DC Electrical Safety Analyzer AC Electrical Safety Analyzer

Quick Start Guide x 1, Power cord x 1, CDx1 (complete user manual), Interlock Key x 1, Remote terminal Cable GHT-119 x 1, Test lead GHT-115 x 1 for GPT-12001/12002/12003, Test lead GHT-115 x 1, GTL-215 x 1 for GPT-12004

Opt.1 GPIB card

GHT-113 GHT-117

High Voltage Test Pistol GRA-440 Rack Adapter Panel (1 High Voltage Adapter Box High Voltage / Ground Bond Adapter Box High Voltage Test Probe RS232C Cable, 9-pin Female to 9-pin, null Modem for Computer USB Cable, A-B type, approx. 1.2m GPIB Cable, approx. 2m GRA-440 Rack Adapter Panel (19', 4U)

GHT-118 GHT-205

GTL-232 GTL-246 GTL-248

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